

650V N-Channel Planar MOSFET

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

650V N-Channel Planar MOSFET

650V N-Channel Planar MOSFET Power Transistor

DD65N12ANx Data Sheet

Rev. 2024 V1.0





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Description

650V N-Channel Planar MOSFET

DD65N12ANx is HRM high voltage MOSFET family based on advanced planar stripe DMOS technology. This advanced MOSFET family has optimized on-state resistance, and also provides superior switching performance and higher avalanche energy strength. This device family is suitable for high efficiency switch mode power supplies.

Features

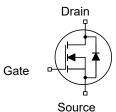
- RDSON=0.64Ω @Vgs=10V, Id=6A
- Ultra Low gate Charge(typical 42.2nC)
- Low Crss (typical 4.6pF)
- Fast switching capability
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant

Applications

- Switch Mode Power Supply
- Uninterruptible Power Supply (UPS)
- TV Power
- A dapter/Charger



TO-220F





Key Performance Parameters

Parameter	Value	Unit
V _{DS}	650	V
R _{DS(on),typ}	0.64	Ω
$Q_{g,typ}$	42.2	nC
I _D	12	A
I _{D,pulse}	48	A

Device Marking and Package Information

Device	Package	Marking
DD65N12ANF	TO-220F	65N12ANF
DD65N12ANFT	TO-220F	65N12ANFT

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Absolute Maximum Ratings T _C = 25°C, unless otherwise noted					
Parameter		Symbol	Value	Unit	
Drain-Source Voltage(V _{GS} =0V)		V _{DS}	650	V	
Continuous Drain Current ¹⁾	T _C = 25°C		12	_	
	T _C = 100°C	I _D	7.5	A	
Pulsed Drain Current ²⁾		I _{D,pulse}	48	А	
Gate-Source Voltage		V _{GS}	±30	V	
Single Pulse Avalanche Energy³)		E _{AS}	792	mJ	
Peak Diode Recovery dv/dt 4)		dv/dt	5	V/ns	
Power Dissipation For TO-220F		P _D	55	W	
Continuous Diode Forward Current		Is	12		
Diode Pulsed Current ²⁾		I _{S,pulse}	48	A	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55~+150	°C	

Thermal Resistance For TO-220F				
Parameter	Symbol	Value	Unit	
Thermal Resistance, Junction-to-Case	R_{thJC}	2.2	°C/W	
Thermal Resistance, Junction-to-Ambient	R _{thJA}	80	- 0/00	

Notes

- 1) Limited by maximum junction temperature.
- 2) Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3) L=11mH, ID=12A, RG=25 Ω , VDD=100V, Start T $_{J}$ =25 $^{\circ}$ C.
- 4) $I_{SD} \le 12A$, di/dt $\le 100A/\mu s$, VDD $\le BV_{DSS}$, Start $T_J = 25$ °C.

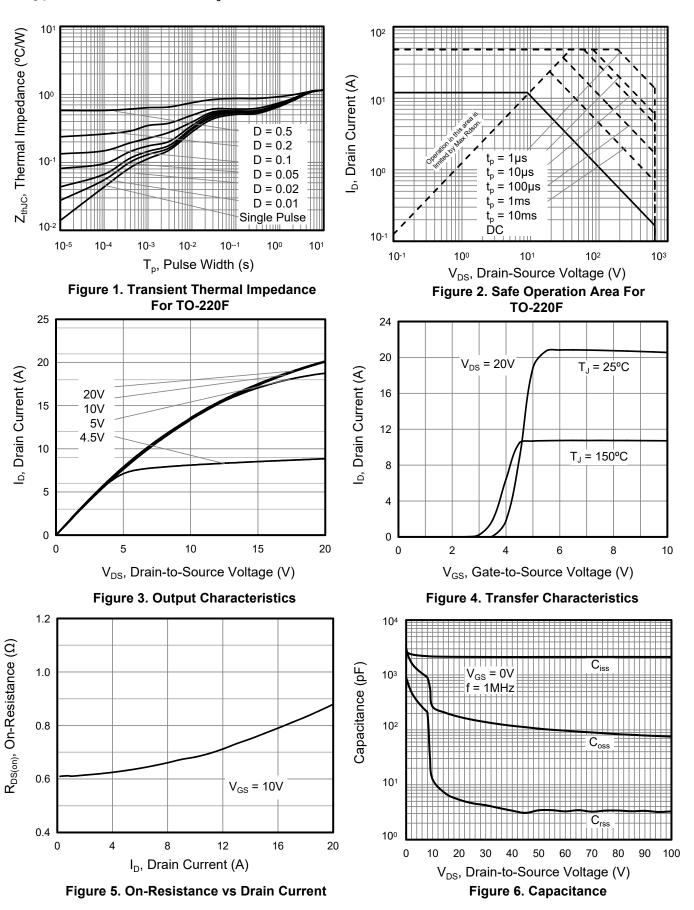
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Parameter	Symbol	Test Conditions	Value			
			Min.	Тур.	Max.	Unit
Static Characteristics	-					
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V
7 0 1 1/4 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		$V_{DS} = 650V$ $V_{GS} = 0V, T_{J} = 25^{\circ}C$			1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 650V,$ $V_{GS} = 0V, T_{J} = 150^{\circ}C$			100	- μA
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = \pm 30V$			±100	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
Drain-Source On-State-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 6A		0.64	0.8	Ω
Gate Resistance	R _G	f = 1.0MHz open drain		2		Ω
Dynamic Characteristics	-					
Input Capacitance	C _{iss}	$V_{GS} = 0V, V_{DS} = 25V$ f = 1.0MHz		2133		pF
Output Capacitance	C _{oss}			152		
Reverse Transfer Capacitance	C _{rss}			4.6		
Total Gate Charge	Q _g			42.2		
Gate-Source Charge	Q_{gs}	$V_{DD} = 520V, I_{D} = 10A$		10.8		nC
Gate-Drain Charge	Q_{gd}	$V_{GS} = 10V$		12.4		
Gate Plateau Voltage	V _{Plateau}			4.7		V
Turn-on Delay Time	t _{d(on)}			31		
Turn-on Rise Time	t _r	V _{DD} = 325V, I _D = 12A		27		
Turn-off Delay Time	t _{d(off)}	$R_G = 25\Omega$, $V_{GS} = 10V$		61		ns
Turn-off Fall Time	t _f			47		
Drain-Source Body Diode Character	ristics			-		
Body Diode Forward Voltage	V _{SD}	$T_J = 25^{\circ}\text{C}, I_{SD} = 12\text{A}$ $V_{GS} = 0\text{V}$			1.2	٧
Reverse Recovery Time	t _{rr}	V _R = 400V		870		ns
Reverse Recovery Charge	Q _{rr}	$I_F = 12A$, $di_F/dt = 100A/\mu s$		9.6		μC



Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted



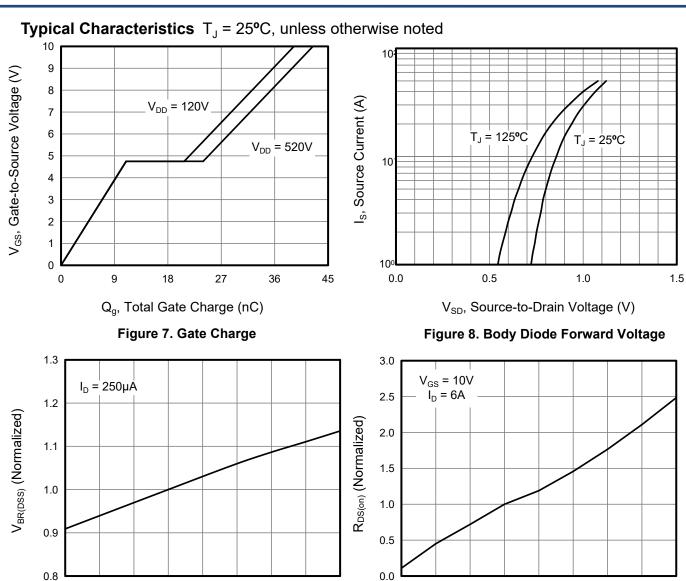


Figure 9. Breakdown Voltage vs
Junction Temperature

Figure 10. On-Resistance vs Temperature

-50

-25

-50

25

50

T_J, Junction Temperature (°C)

75

100

125

150

50

75

100

125

150

25

T_J, Junction Temperature (°C)

Figure A: Gate Charge Test Circuit and Waveform

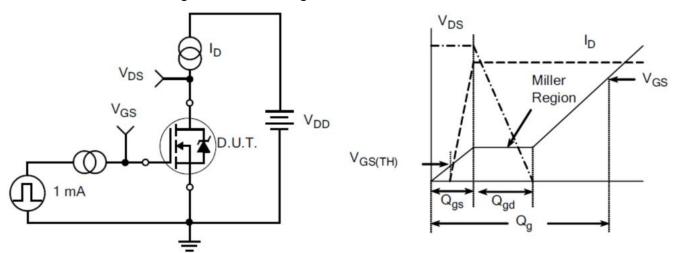


Figure B: Resistive Switching Test Circuit and Waveform

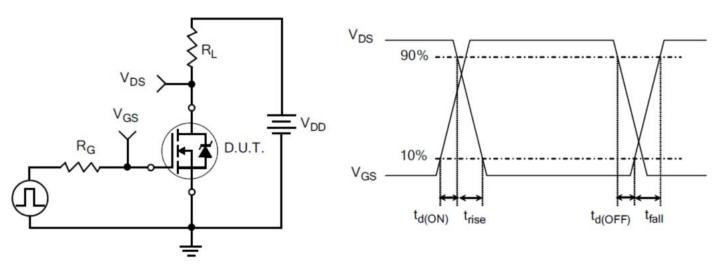
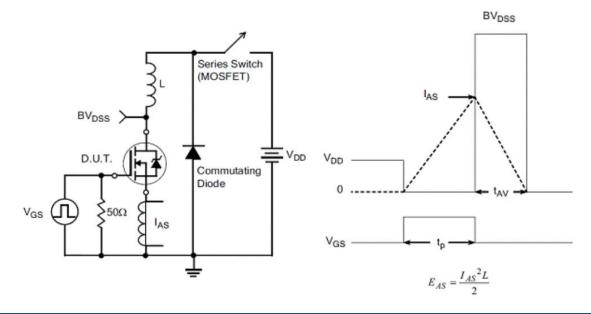
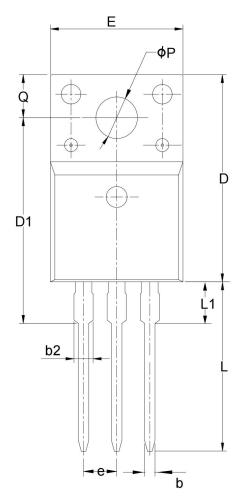


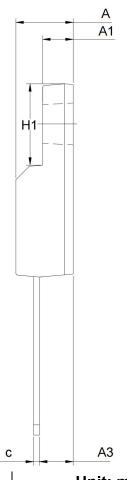
Figure C: Unclamped Inductive Switching Test Circuit and Waveform





Outlines TO-220F Package





SYMBOL	Unit: mm		
STWIDOL	MIN	MAX	
Α	4.45	4.9	
A1	2.3	2.8	
A3	2.5	3.03	
b	0.65	0.95	
b2	1.28	1.56	
С	0.4	0.65	
D	15.5	16.24	
D1	15.27	16.07	
E	9.91	10.36	
е	2.54BSC		
H1	6.48	6.88	
L	12.5	13.6	
L1	2.6	3.5	
ФР	3.03	3.48	
Q	3.1	3.5	

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